

Some novel design features of the LBL metal vapor vacuum arc ion sources

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The family of MEVVA (metal vapor vacuum arc) high current metal ion sources developed at LBL over the past several years has grown to include a number of different source versions with a wide range of some of the design and operational parameters. The MicroMEVVA source is a particularly compact version, about 2 cm diam and 10 cm long, while the MEVVA IV weighs some 30 kG. MEVVA IV and V incorporate multiple cathode assemblies (16 and 18 separate cathodes, respectively), and the operating cathode can be switched rapidly and without downtime. The new MEVVA V embodiment is quite compact considering its broad beam (10 cm), high voltage (100 kV), and multiple cathode features. The large-area extractor grids used in MEVVA V were fabricated using a particularly simple technique, and they are clamped into position and can thus be changed simply and quickly. The electrical system used to drive the arc is particularly simple and incorporates several attractive features. In this article we review and describe a number of the mechanical and electrical design features that have been developed for these sources.

INTRODUCTION

The MEVVA (metal vapor vacuum arc) high current metal ion sources that have been developed at the Lawrence Berkeley Laboratory were made initially for the purpose of providing intense uranium ion beams for injection into the Bevalac heavy ion synchrotron^{1,2} for basic nuclear physics experiments. Since then it has become apparent that this kind of ion source is also of value for other applications, including ion implantation for metallurgical surface modification. Consequently, the source has been developed in a number of ways with these specific applications in mind.

In the overall LBL MEVVA R&D program, a total of five quite different sources have been designed and constructed, MEVVA I–V, as well as two different versions of miniaturized sources, MicroMEVVA I and II. A photograph of three of these sources—the MEVVA II, MEVVA IV, and MicroMEVVA II—is shown in Fig. 1. These different sources all have their different characteristics and performance parameters, and in the process of their development a number of unique and interesting features have been used. Here we describe a number of these interesting characteristics.

I. DESCRIPTION OF THE SOURCES

Following initial trials made on a relatively primitive first test version, the MEVVA II device was made and this has served as the “laboratory workhorse” for several years now. This is a single-cathode embodiment with a maximum extraction voltage of around 70 kV, and an extractor diameter of up to 2 cm, which can readily produce a beam current of several hundred milliamperes in typical operation. Note that to date all of the sources have been designed and operated in a pulsed mode, with a pulse length in the approximate range 0.1–5.0 ms and a repetition rate of up to a maximum of about 100 pps (depending on arc and beam currents and the

pulse length). Pulsed operation is not an inherent limitation of this kind of ion source, but has evolved because of the low duty cycle pulsed nature of the synchrotron for which the sources were initially designed. The MEVVA II ion source has been described in several publications.^{3–6}

II. MEVVA IV

The principal novelty introduced in the MEVVA IV source is the multiple cathode feature. A multi-cathode assembly holds 16 separate cathodes, and by rotating the assembly externally any one of these cathodes can be brought into operation. At present, the rotation (cathode switching) is performed manually, but clearly this could be automated with an electromechanical or air operated switching mechanism. The cathodes can be of the same or different metallic elements, thus increasing the effective lifetime of the source between scheduled maintenance periods (cathode replacement) by a factor of 16, or increasing the range of ion species

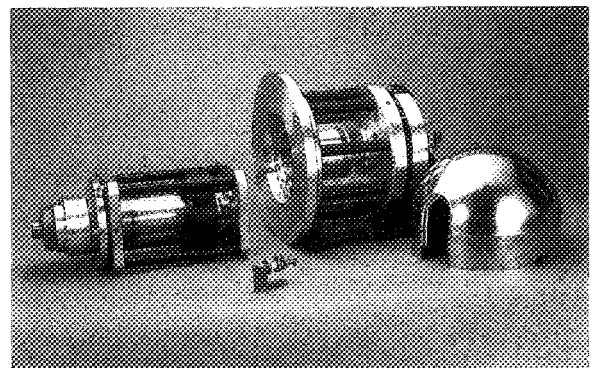


FIG. 1. MEVVA II (left), MEVVA IV with corona shield removed (right), and the MicroMEVVA II (foreground).

that can be simply switched into operation in a single experimental run. A photograph displaying the multiple cathode assembly is shown in Fig. 2.

The MEVVA IV can operate with a beam extraction voltage of up to 100 kV. The beam formation grids are similar to those used in the MEVVA II source, i.e., of 2 cm diam, and the beam current that can be produced is similar also. The performance of the MEVVA IV device is summarized in a companion paper.⁷

III. MEVVA V

In MEVVA V we increased the size of the beam formation grids by a large factor, while maintaining the multiple cathode and high voltage features developed for MEVVA IV. The extractor grids are 10 cm in diameter. For good usage of this large area it is necessary to present the metal plasma, from which the beam is to be formed, to the grids with a relatively uniform ion density profile across the extractor dimension; otherwise, the beam optics will be poor, and breakdown between the grids will occur at relatively low voltage. Thus, this source also incorporates a plasma expansion chamber in which the metal plasma plume generated at the cathode is allowed to expand to large size (comparable to the grid dimension) prior to beam formation and in which a samarium cobalt permanent magnet multipole structure can be included.

The grids were made using commercially available perforated metal sheet with hexagonal hole pattern. Although some drilling out and touching up of the beamlet extractor holes was necessary, by purchasing the predrilled sheet a great deal of layout and machine time was saved. This kind of perforated material is available in a wide range of hole size and for several different metals.

The multiple cathode feature was maintained, and, in fact, the number of individual cathodes was increased to 18. The cooling of the source was increased and made more efficient, and we expect that the power dissipation capability, which translates into pulse repetition rate and mean beam current, has also been increased. The cylindrical vacuum chamber is of alumina construction, and although its length is quite short, about 12 cm, an extraction voltage of nearly 100 kV in operation can be held. A photograph of the

MEVVA V source is shown in Fig. 3. The MEVVA V source is still undergoing its commissioning process, and the performance results that we have obtained to date are summarized in a companion paper to this article.⁸

IV. MICROMEVVA

Two versions of miniature sources have been made. Both of these sources are of overall length of about 10 cm, diameter of about 2 cm, and mass of about 100 g. They are fabricated from coaxially fitting stock ceramic and stainless-steel tubing, and are of particularly simple design. Beam extraction is done in an unsophisticated manner through a single aperture of diameter about 3 mm, and the maximum extraction voltage that can be maintained across the short distances is about 20 kV. Pulsed beam current is up to 10 or 20 mA. The entire source resides within the vacuum, and the cooling is minimal; thus, the pulse repetition frequency (mean arc and beam current) is limited too. The MicroMEVVA sources have found useful application as high vacuum metal ion injectors into EBIS (electron beam ion source) devices.⁹ The MicroMEVVA I (assembled) and the MicroMEVVA II (partially disassembled) are shown in Figs. 4(a) and 4(b).

V. ELECTRICAL SYSTEM

Because of quite severe economic constraints, we have been obliged to make simple and inexpensive ion source electronics and electrical support systems. The main parts of the overall system are the extractor power supply, the arc power supply, and the trigger generator. The extractor system makes use of an unfiltered high voltage power supply that charges a high voltage capacitor of 0.16 μF ; the capacitor then serves as the power supply seen by the ion source. Thus, the high voltage is applied across the extractor grids dc, and current is drawn only when the arc pulse is supplied to generate the metal plasma. The arc is initiated by a trigger pulse applied between the ion source trigger electrode and the cathode, at a level of roughly 10 kV and of some microseconds duration. At present, the trigger generator uses switched air spark gaps.

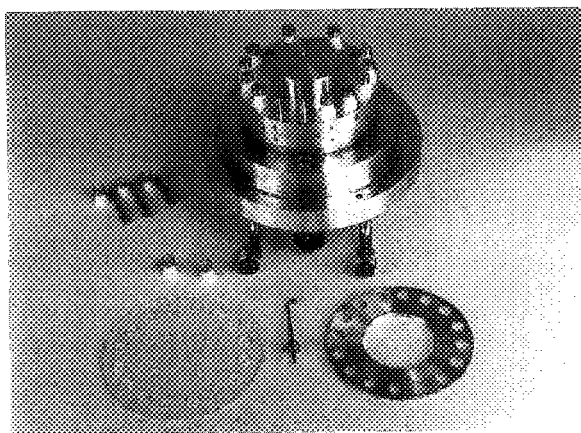


FIG. 2. The MEVVA IV multiple cathode assembly, partially disassembled.

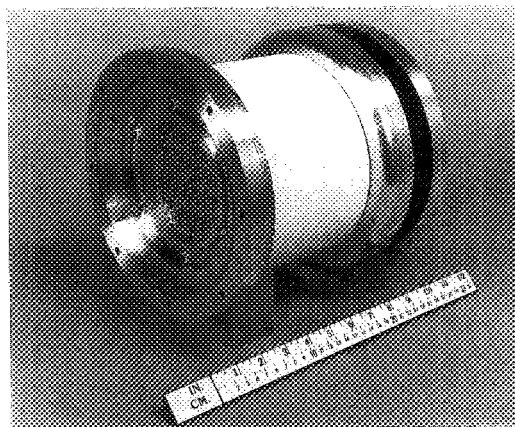


FIG. 3. The MEVVA V ion source.

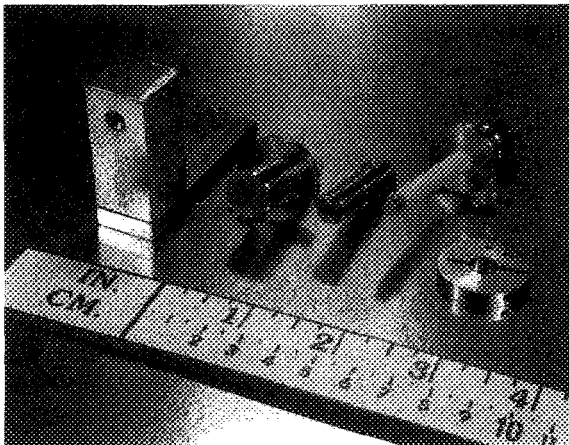
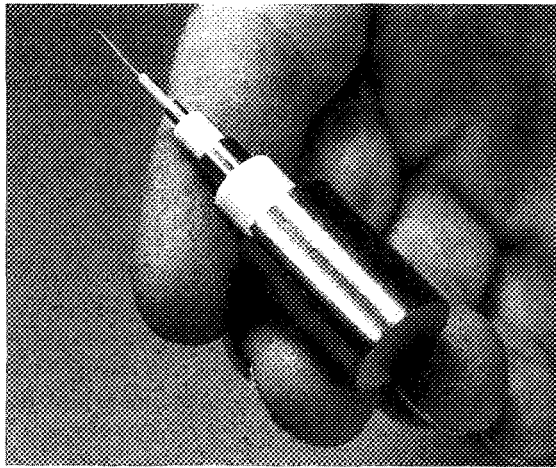


FIG. 4. (a) MicroMEVVA I (assembled), and (b) MicroMEVVA II (partially disassembled).

The arc current is supplied by an LC (inductance-capacitance) pulse line of impedance of order 1Ω (our present line has $Z_0 = 1.5\Omega$), and pulse length several hundred microseconds ($250\mu\text{s}$ in our present version). The line output is connected across the ion source anode and cathode, and discharges into the vacuum arc when the trigger pulse is applied. We have incorporated several interesting features into the pulse line design that have greatly increased the ion source operation reliability:

(i) A modified Gibbs section has been added to the front of the LC line to sharpen the risetime of the current pulse. This is simply a series RC (resistance-capacitance) combination with $R = Z_0$ and C the same as the other capacitors in the pulse line. The effect of this addition is to supply a small increment of current at early time, i.e., to sharpen the pulse and help to establish the vacuum arc quickly.

(ii) A prearc feature has been added, whereby a separate capacitor is discharged into the vacuum arc for the first few tens of microseconds, also helping to establish the arc at early times. This capacitor is charged to a higher voltage than the LC pulse line (we use a voltage doubler from the same power supply that charges the LC line), thus enabling the arc to establish even when the line charging voltage is low.

(iii) An efficiency enhancing diode is included,

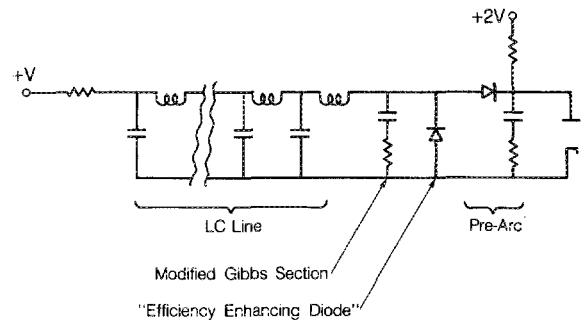


FIG. 5. Schematic of typical MEVVA arc power supply.

whereby the charge that would otherwise be dumped into the line capacitors in the reverse direction after each discharge is caused to actually partially charge the line with the correct polarity. Thus, the amount of charging current needed for the subsequent discharge is reduced and the pulse repetition frequency can be increased, for fixed mains power supply current. These features can be seen in the arc circuit shown schematically in Fig. 5.

VI. CONCLUSIONS

Several different embodiments of the MEVVA ion source have been developed as part of the LBL program, incorporating a number of unique and interesting features that enhance the source operation. Characteristics of importance include multiple cathodes and the ability to switch between cathode materials simply and quickly, high voltage operation, and broad beam source version, as well as miniature versions. Also, several novel features have been incorporated into the electrical systems to increase the source operational reliability. The MEVVA R&D program is ongoing, and it is expected that further improvements in the source mechanical and electrical design features will be made.

ACKNOWLEDGMENTS

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